

MOSFET

OptiMOS[™] 5 Power-Transistor, 60 V

Features

- Ideal for high frequency switching and sync. rec.
 Excellent gate charge x R_{DS(on)} product (FOM)
 Very low on-resistance R_{DS(on)}
 N-channel, normal level

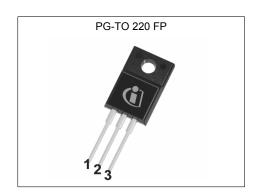
- 100% avalanche tested
- Pb-free plating; RoHS compliant
 Halogen-free according to IEC61249-2-21

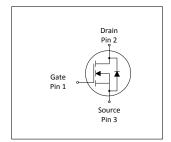
Product validation

Qualified according to JEDEC Standard

Table 1 **Key Performance Parameters**

- unio : itely : ellerimanico : unuminotero								
Parameter	Value	Unit						
V _{DS}	60	V						
R _{DS(on),max}	4	mΩ						
I _D	72	A						
Qoss	44	nC						
Q _G (0V10V)	38	nC						











Type / Ordering Code	Package	Marking	Related Links
IPA040N06NM5S	PG-TO 220 FullPAK	040N065S	-

OptiMOSTM 5 Power-Transistor, 60 V IPA040N06NM5S



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OptiMOS[™] 5 Power-Transistor, 60 V IPA040N06NM5S



1 Maximum ratings at T_A =25 °C, unless otherwise specified

Maximum ratings Table 2

Parameter	Cumbal	Values			1114	
	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition
Continuous drain current	I _D	-	-	72 51	А	V _{GS} =10 V, T _C =25 °C V _{GS} =10 V, T _C =100 °C
Pulsed drain current ¹⁾	I _{D,pulse}	-	-	288	Α	<i>T</i> _C =25 °C
Avalanche energy, single pulse ²⁾	E AS	-	-	77	mJ	$I_{\rm D}$ =72 A, $R_{\rm GS}$ =25 Ω
Gate source voltage	V _{GS}	-20	-	20	V	-
Power dissipation	P _{tot}	-	-	36	W	<i>T</i> _C =25 °C
Operating and storage temperature	T _j , T _{stg}	-55	-	175	°C	IEC climatic category; DIN IEC 68-1: 55/175/56

2 Thermal characteristics

Table 3 Thermal characteristics

Davamatav	Symbol	Values			l lmit	Nata / Task Ossalition	
Parameter	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition	
Thermal resistance, junction - case	R _{thJC}	-	-	4.2	°C/W	-	

3 Electrical characteristics at T_j =25 °C, unless otherwise specified

Static characteristics Table 4

Parameter	0		Values			
	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition
Drain-source breakdown voltage	V _{(BR)DSS}	60	-	-	V	V _{GS} =0 V, I _D =1 mA
Gate threshold voltage	V _{GS(th)}	2.1	2.8	3.3	V	$V_{\rm DS}$ = $V_{\rm GS}$, $I_{\rm D}$ =50 μA
Zero gate voltage drain current	I _{DSS}	-	0.1 10	1 100	μΑ	V _{DS} =60 V, V _{GS} =0 V, T _j =25 °C V _{DS} =60 V, V _{GS} =0 V, T _j =125 °C
Gate-source leakage current	I_{GSS}	-	10	100	nA	V _{GS} =20 V, V _{DS} =0 V
Drain-source on-state resistance	R _{DS(on)}	-	3.6 4.7	4.0	mΩ	V _{GS} =10 V, I _D =72 A V _{GS} =6 V, I _D =18 A
Gate resistance ³⁾	R _G	-	1.3	-	Ω	-
Transconductance	g fs	-	110	-	S	$ V_{DS} \ge 2 I_D R_{DS(on)max}, I_D = 72 A$

See Diagram 3 for more detailed information
 See Diagram 13 for more detailed information
 Defined by design. Not subject to production test.

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Table 5 Dynamic characteristics

Damamatan	Cumbal	Values			I I mid	Nata / Tank Canadikian
Parameter	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition
Input capacitance ¹⁾	Ciss	-	2700	3500	pF	V _{GS} =0 V, V _{DS} =30 V, <i>f</i> =1 MHz
Output capacitance	Coss	-	670	-	pF	V _{GS} =0 V, V _{DS} =30 V, f=1 MHz
Reverse transfer capacitance	C _{rss}	-	28	-	pF	V _{GS} =0 V, V _{DS} =30 V, f=1 MHz
Turn-on delay time	$t_{ m d(on)}$	-	14	-	ns	$V_{\rm DD}$ =30 V, $V_{\rm GS}$ =10 V, $I_{\rm D}$ =72 A, $R_{\rm G,ext}$ =3 Ω
Rise time	t _r	-	16	-	ns	$V_{\rm DD}$ =30 V, $V_{\rm GS}$ =10 V, $I_{\rm D}$ =72 A, $R_{\rm G,ext}$ =3 Ω
Turn-off delay time	$t_{ m d(off)}$	-	33	-	ns	$V_{\rm DD}$ =30 V, $V_{\rm GS}$ =10 V, $I_{\rm D}$ =72 A, $R_{\rm G,ext}$ =3 Ω
Fall time	t _f	-	8	-	ns	$V_{\rm DD}$ =30 V, $V_{\rm GS}$ =10 V, $I_{\rm D}$ =72 A, $R_{\rm G,ext}$ =3 Ω

Table 6 Gate charge characteristics²⁾

Parameter	0	Values				
	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition
Gate to source charge	Q _{gs}	-	13	-	nC	$V_{\rm DD}$ =30 V, $I_{\rm D}$ =72 A, $V_{\rm GS}$ =0 to 10 V
Gate charge at threshold	$Q_{g(th)}$	-	8	-	nC	$V_{\rm DD}$ =30 V, $I_{\rm D}$ =72 A, $V_{\rm GS}$ =0 to 10 V
Gate to drain charge	Q _{gd}	-	7	-	nC	$V_{\rm DD}$ =30 V, $I_{\rm D}$ =72 A, $V_{\rm GS}$ =0 to 10 V
Switching charge	Q _{sw}	-	13	-	nC	$V_{\rm DD}$ =30 V, $I_{\rm D}$ =72 A, $V_{\rm GS}$ =0 to 10 V
Gate charge total ¹⁾	Qg	-	38	50	nC	$V_{\rm DD}$ =30 V, $I_{\rm D}$ =72 A, $V_{\rm GS}$ =0 to 10 V
Gate plateau voltage	V _{plateau}	-	4.9	-	V	$V_{\rm DD}$ =30 V, $I_{\rm D}$ =72 A, $V_{\rm GS}$ =0 to 10 V
Gate charge total, sync. FET	Q _{g(sync)}	-	33	-	nC	V _{DS} =0.1 V, V _{GS} =0 to 10 V
Output charge	Q _{oss}	-	44	-	nC	V _{DD} =30 V, V _{GS} =0 V

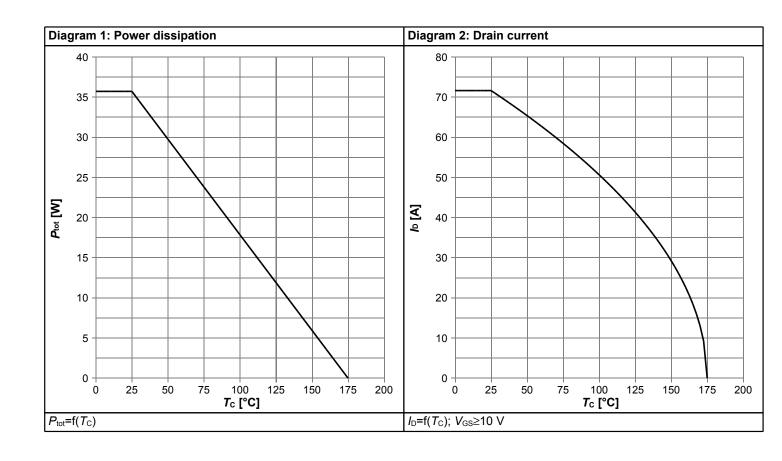
Table 7 Reverse diode

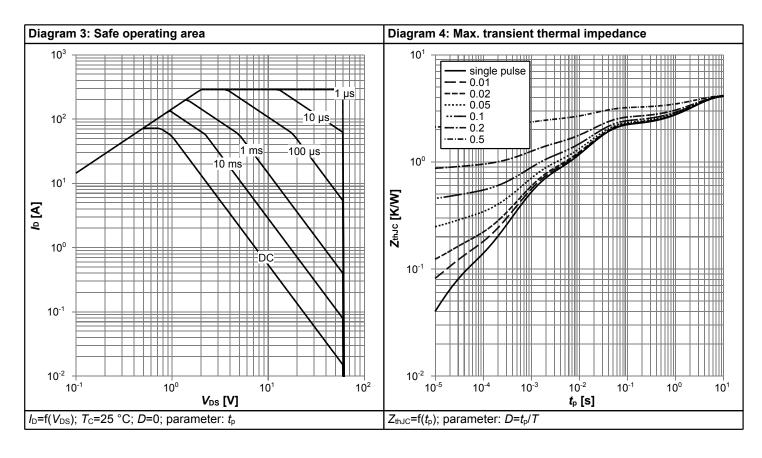
Parameter	Cumbal		Values			Nata / Taat Candition
	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition
Diode continuous forward current	Is	-	-	30	Α	T _C =25 °C
Diode pulse current	I _{S,pulse}	-	-	288	Α	T _C =25 °C
Diode forward voltage	V _{SD}	-	0.88	1.2	V	V _{GS} =0 V, I _F =30 A, T _j =25 °C
Reverse recovery time ¹⁾	t _{rr}	-	33	-	ns	V _R =30 V, I _F =30 A, di _F /dt=100 A/μs
Reverse recovery charge ¹⁾	Qrr	-	28	-	nC	V _R =30 V, I _F =30 A, di _F /dt=100 A/μs

 $^{^{1)}}$ Defined by design. Not subject to production test. $^{2)}$ See "Gate charge waveforms" for parameter definition

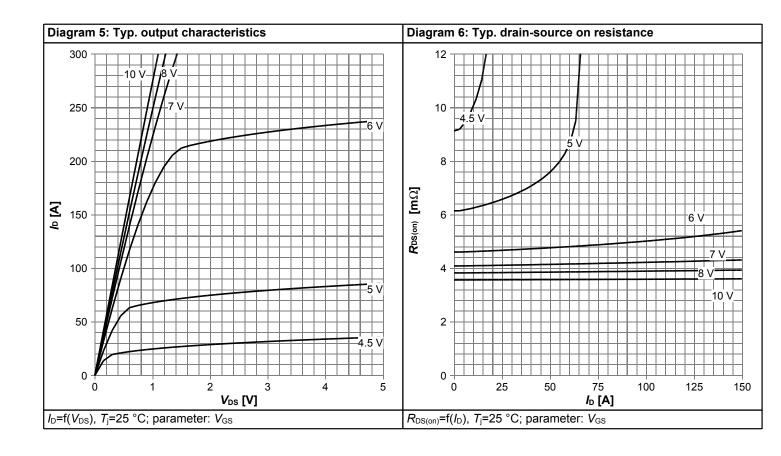


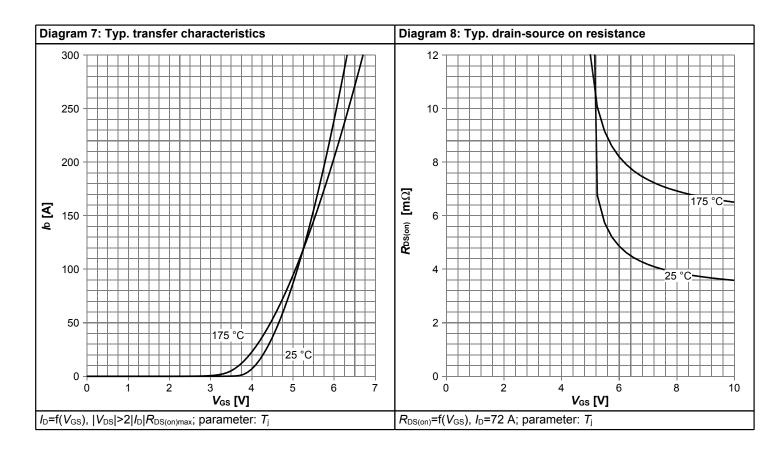
4 Electrical characteristics diagrams



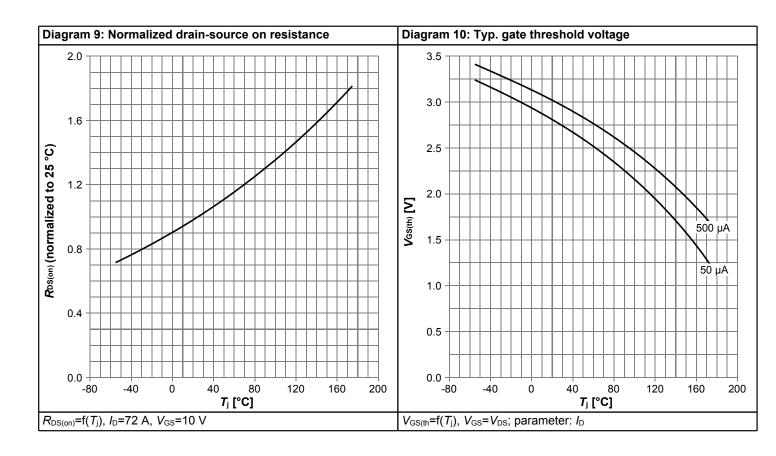


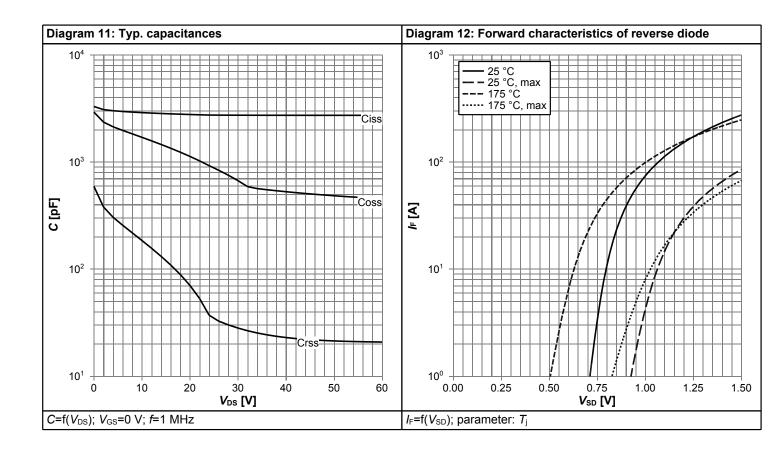




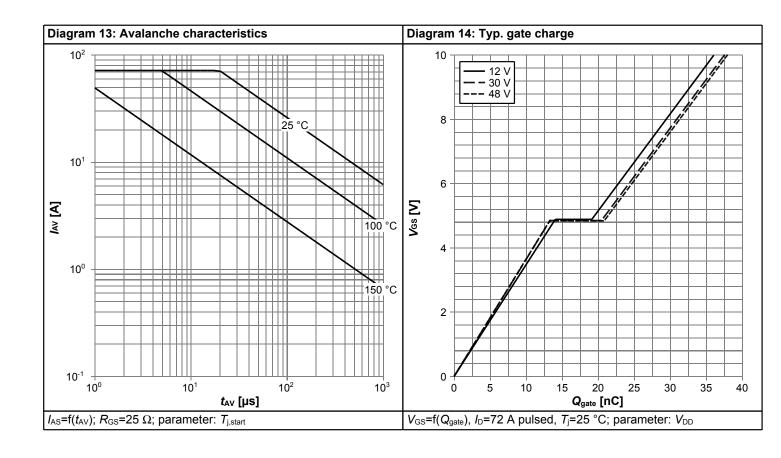


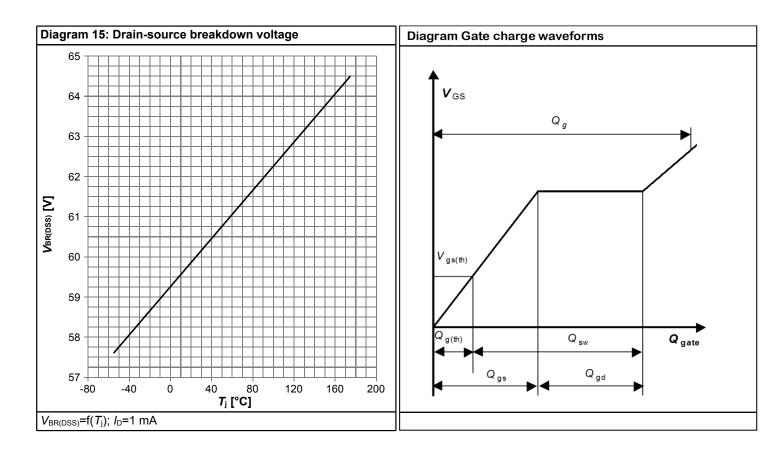














5 Package Outlines

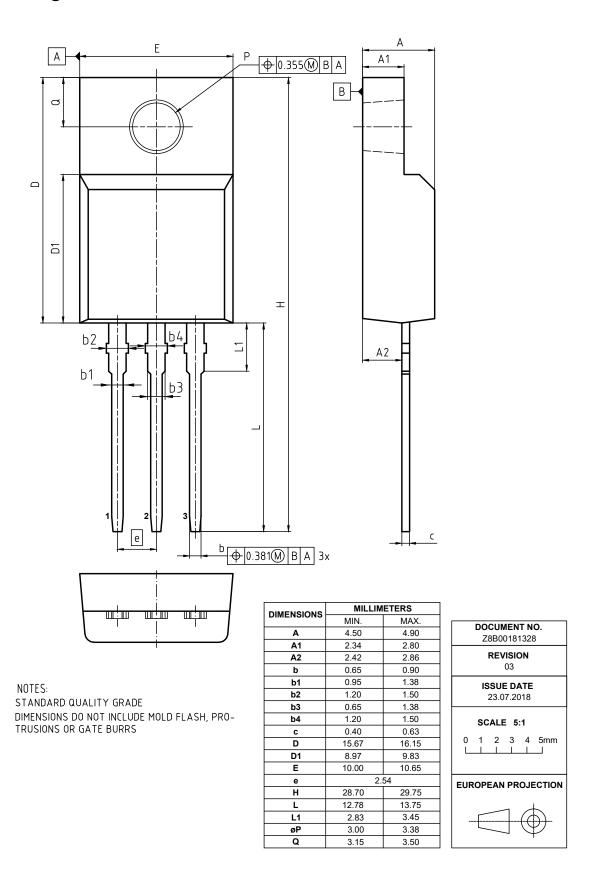


Figure 1 Outline PG-TO 220 FullPAK, dimensions in mm/inches

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IPA040N06NM5S



Revision History

IPA040N06NM5S

Revision: 2019-09-02, Rev. 2.1

Drawiana	Revision
PIAMMIC	RAWKINN

Revision	Date	Subjects (major changes since last revision)				
2.0	2019-07-16	Release of final version				
2.1	2019-09-02	Update package outline				

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